

Notice of References Cited

Application/Control No.

10/523,107

Applicant(s)/Patent Under
Reexamination
INOUE ET AL.

Examiner

MINH D. A

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,087,757	07-2000	Honbo et al.	310/316.01
*	B	US-6,593,707	07-2003	Shih, Wen-Chu	315/277
*	C	US-6,661,181	12-2003	Shin, Chung-Hyuk	315/169.4
*	D	US-6,570,344	05-2003	Lin, Yung-Lin	315/224
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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